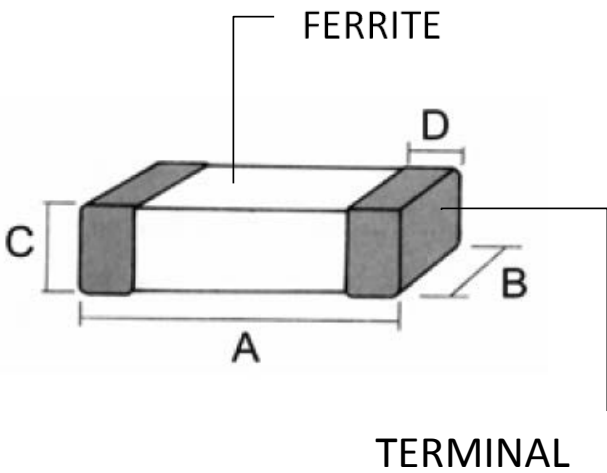


Specification For Approval

Multilayer chip bead 1608 (0603) series

SHAPES		ELECTRICAL CHARACTERISTIC	
 <p>The diagram shows a rectangular chip bead with a central ferrite core and terminal layers on both ends. Dimension A is the total length, B is the terminal width, C is the terminal thickness, and D is the ferrite thickness.</p>		$Z \pm 25\%$	10 Ω ~ 600 Ω
		DCR (Ω) MAX.	0.030 Ω ~ 0.300 Ω
		RATED CURRENT (A) MAX.	1.0 A ~ 4.0 A
DIMENSIONS		TEST FREQUENCY	
A m/m	1.6 \pm 0.2	100 MHz / 0.5V	
B m/m	0.8 \pm 0.2		
C m/m	0.8 \pm 0.2	TEST EQUIPMENT	
D m/m	0.3 \pm 0.2	HP-4438A MILLIOHMMETER	
		HP-4291A IMPEDANCE ANALYZER	

ORDERING CODE :

BCCB-XXXX□ - XXX□

(1) (2) (3) (4) (5)

(1) Product Code

(2) Dimensions

(3) Material Code

E1 : Standard Speed E2 : High Speed ES : High Current

(4) Impedance

(5) Taping

L : 1000mA N : 2000mA P : 2500mA Q : 3000mA

R : 4000mA U : 5000mA W : 6000mA

Multilayer chip bead 1608 (0603) series

PRODUCT INSPECTION SPECIFICATIONS

FINISHED PRODUCT INSPECTIONS

Inspection Item	Sampling Plan	AQL	Inspection Equipment
L/Z	MIL-STD-105E LII (Normal Inspection)	0.1	HP4291A/B
Q	MIL-STD-105E LII (Normal Inspection)	0.1	
DCR	MIL-STD-105E LII (Normal Inspection)	0.015	HP4338A/B
OPEN	Q'ty.×3 %	c=0	HP4338A/B
Dimension	n=20	c=0	Calipers
Appearance	MIL-STD-105E LII (Normal Inspection)	0.1	Inspection Machine 8X/50X Magnifier 100X Microscope

TAPE & REEL INSPECTIONS

Inspection Item	Sampling Plan	AQL	Inspection Equipment
Peeling Force	One Reel Per Lot	c=0	Peeling Force Tester
Reel(Quantity)	Full Inspection	c=0	Visual
P/N Label	Full Inspection	c=0	Visual

Specification For Approval

Multilayer chip bead 1608 (0603) series

Part Number	Impedance (Ω) $\pm 25\%$ At 100MHz	DC Resistance (Ω) MAX.	Rated Current (A) MAX.
BCCB-1608ES-100R	10	0.03	4
BCCB-1608ES-190Q	19	0.04	3
BCCB-1608ES-300Q	30	0.05	3
BCCB-1608ES-600Q	60	0.05	3
BCCB-1608ES-800Q	80	0.04	3
BCCB-1608ES-121P	120	0.10	2.5
BCCB-1608ES-221N	220	0.15	2
BCCB-1608ES-301N	300	0.15	2
BCCB-1608ES-331N	330	0.10	2
BCCB-1608ES-601L	600	0.30	1
BCCB-1608ES-152K	1500	0.50	0.5

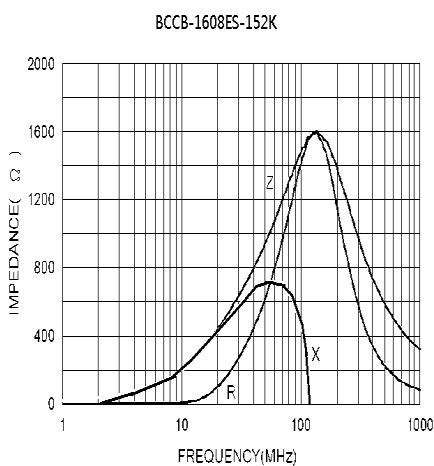
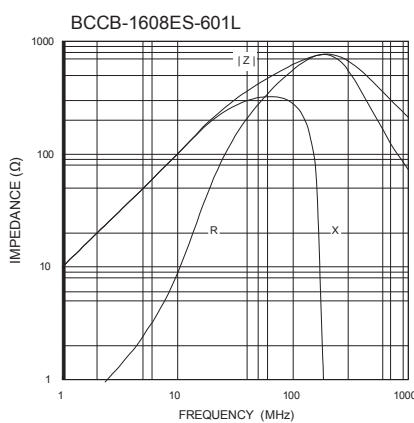
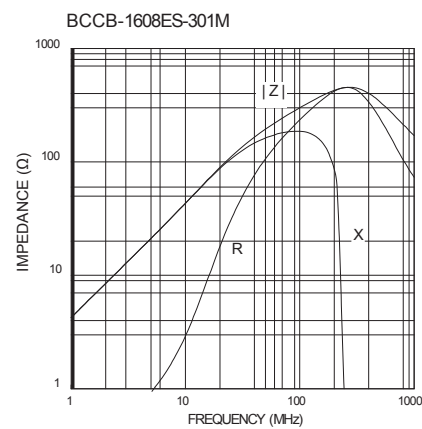
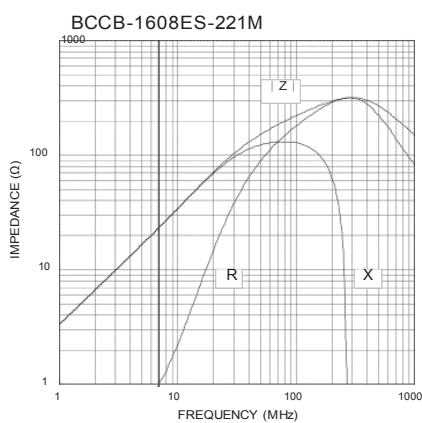
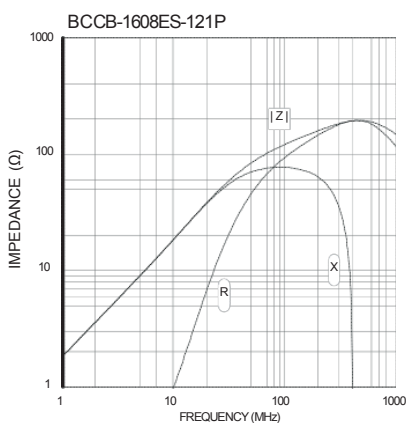
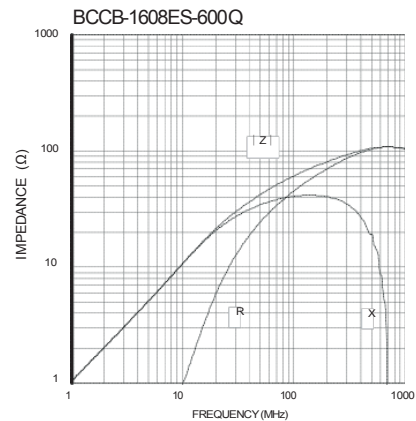
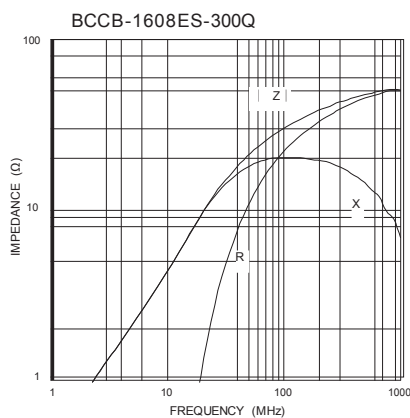
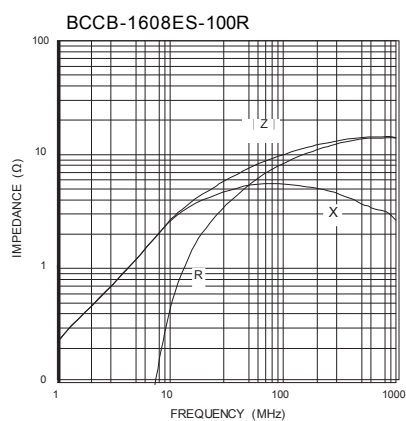
Specification For Approval

Multilayer chip bead 1608 (0603) series

IMPEDANCE VS. FREQUENCY CHARACTERISTIC

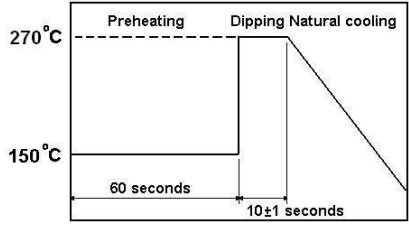
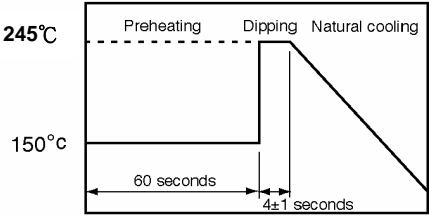
TEST INSTRUMENT :

HP 4291A RF IMPEDANCE/MATERIAL ANALYZER



Multilayer chip bead 1608 (0603) series

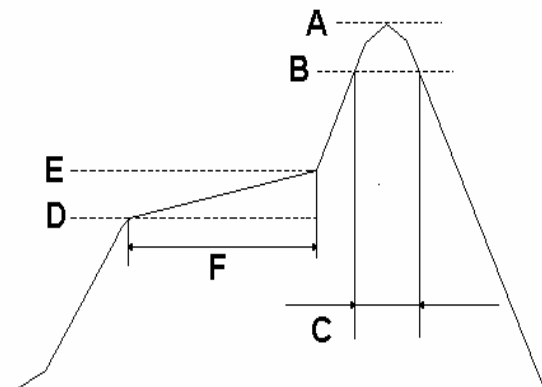
RELIABILITY TEST

Item	Performance	Test condition
Operating temperature range	-55 °C to + 125 °C	
Storage temperature and umidity ranges	40 °C MAX., 70% RH MAX.	
Soldering heat resistance	The chip shall not be cracks. More than 75% of terminal electrode shall be covered with solder.	Preheat: 150 °C, 60 seconds Solder temperature : 270 ± 5 °C Flux: Rosin Dip time: 10 ± 1 seconds 
Solderability	More than 90% of the terminal electrode shall be covered with new solder.	Preheat: 150 °C, 60 seconds Solder temperature: 245 ± 5 °C Flux: Rosin Dip time: 4 ± 1 seconds 

Recommended Soldering Conditions

(REFLOW TEMPERATURE PROFILE) **Lead-Free**

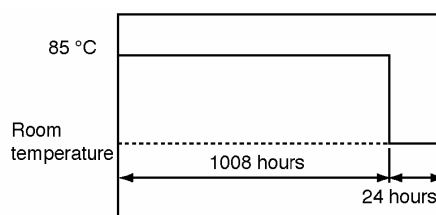
A	$260 \pm 5^{\circ}\text{C}$
B	$230 \pm 5^{\circ}\text{C}$
C	$30 \pm 10 \text{ sec}$
D	150°C
E	180°C
F	$90 \pm 30 \text{ sec}$



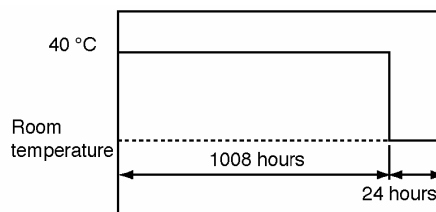
RELIABILITY TEST

Item	Performance	Test condition
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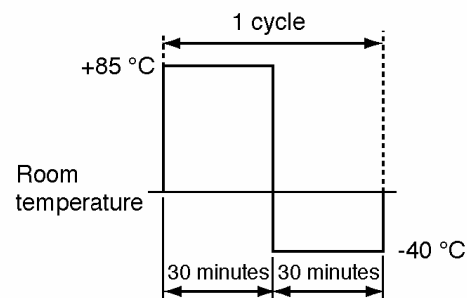
High temperature resistance	Appearance: Ferrite shall not be damaged. Impedance: Within±20% of the initial value.	Temperature: 85±2°C Testing time: 1008±12 hours Measurement: After placing for 24 hours min.
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Humidity resistance	Appearance: Ferrite shall not be damaged. Impedance: Within±20% of the initial value	Humidity: 90 to 95% RH Temperature: 40±2°C Testing time: 1008±12 hours Measurement: After placing for 24 hours min.
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Thermal Shock	Appearance: Cracking, chipping or any other defects harmful to the characteristics shall not be allowed. Impedance: Within±20% of the initial value	Temperature: -40°C, +85°C, kept stabilized for 30 minutes each Cycle: 100 cycles Measurement: After placing for 24 hours min.
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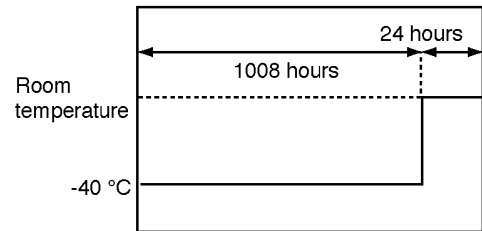
Specification For Approval

Multilayer chip bead 1608 (0603) series

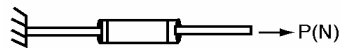
RELIABILITY TEST

Item	Performance	Test condition
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Low temperature storage life test	Appearance: Cracking, chipping or any other defects harmful to the characteristics shall not be allowed. Impedance: Within $\pm 20\%$ of the initial value.	Temperature: $-40 \pm 2^\circ\text{C}$ Testing time: 1008 ± 12 hours Measurement: After placing for 24 hours min.
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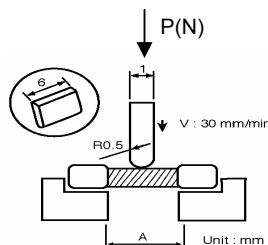


Terminal strength
The terminal electrode and the body shall not be damaged by the forces applied on the right conditions.



Type	P (kgf)	Time (s)
BCCB-1005□	0.3	30 ± 5
BCCB-1608□	0.5	
BCCB-2012□	0.6~0.8	
BCCB-3216□	1.0	

Bending strength
The body shall not be damaged by the forces applied on the right conditions.

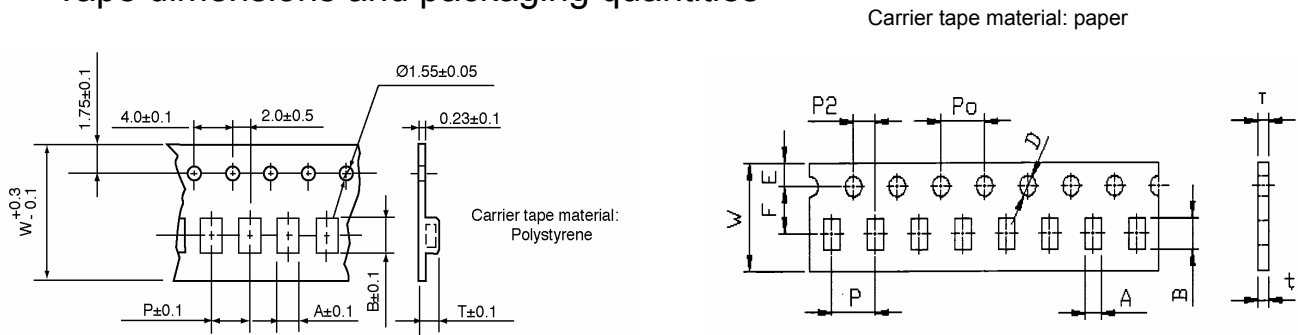


Type	A (mm)	P (kgf)
BCCB-1608□	1.0	0.5
BCCB-2012□	1.4	1.0
BCCB-3216□	2.0	2.0

Specification For Approval

Multilayer chip bead 1608 (0603) series

● Tape dimensions and packaging quantities

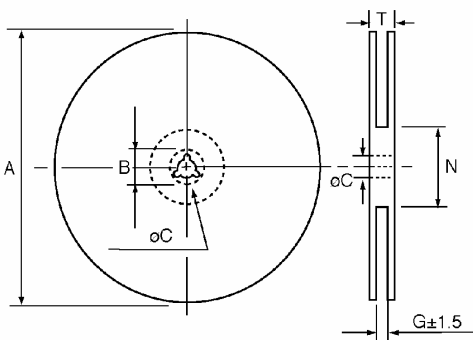


material: Paper (Dimensions in mm)						
TYPE	A	B	W	P	T	CHIPS / REEL
BCCB-1005□	0.62	1.12	8	2	0.60	10000
BCCB-1608□	1.10	1.90	8	4	0.95	4000
BCCB-2012□	1.50	2.30	8	4	0.95	4000
material: Polystyrene (Dimensions in mm)						
TYPE	A	B	W	P	T	CHIPS / REEL
BCCB-1608□	1.01	1.80	8	4	1.02	4000
BCCB-2012□	1.42	2.25	8	4	1.04	4000
BCCB-3216□	1.88	3.50	8	4	1.27	3000

● Reel dimensions

Material: Paper, Plastic

Dimensions in mm



TYPE	8mm	12mm
A	178±2	178±2
B	21.0±0.8	21.0±0.8
C	13.0±0.8	13.0±0.8
G	10.0	14.0
N	75	75
T	12.5	16.5

